



60V DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)}	I _D T _A = +25°C
60V	66mΩ @ V _{GS} = 10V	4.4A
60 V	97mΩ @ V _{GS} = 4.5V	3.6A

Features and Benefits

- Low on-resistance
- Fast switching speed
- 100% Unclamped Inductive Switch (UIS) test in production
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

Description and Applications

This MOSFET is designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

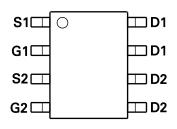
- Motor Control
- Backlighting
- DC-DC Converters
- Power Management Functions

Mechanical Data

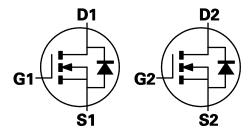
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram Below
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 [®]
- Weight: 0.074 grams (Approximate)



Top View



Top View



Equivalent Circuit

Ordering Information (Notes 4 & 5)

Part Number	Compliance	Case	Packaging
DMN6066SSD-13	Commercial	SO-8	2,500/Tape & Reel
DMN6066SSDQ-13	Automotive	SO-8	2,500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www. diodes.com/quality/product_grade_definitions/.
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

SO-8



Oll = Manufacturer's Marking
N6066SD = Product Type Marking Code
YYWW = Date Code Marking
YY = Year (ex: 09 = 2009)
WW = Week (01 - 53)



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Drain-Source Voltage		V_{DSS}	60	V	
Gate-Source Voltage		(Note 6)	V _{GS}	±20	V
Single Pulsed Avalanche En	ergy	(Note 13)	E _{AS}	37.5	mJ
Single Pulsed Avalanche Cu	irrent	(Note 13)	I _{AS}	5.0	Α
Continuous Drain Current V _{GS} = 10V		(Note 8)		4.4	
	$V_{GS} = 10V$	$T_A = +70^{\circ}C \text{ (Note 8)}$	I _D	3.5	Α
		(Note 7)		3.3	
Pulsed Drain Current	$V_{GS} = 10V$	(Note 9)	I _{DM}	17.0	Α
Continuous Source Current	(Body diode)	(Note 8)	Is	3.2	Α
Pulsed Source Current (Bod	y diode)	(Note 9)	I _{SM}	17.0	Α

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
	(Notes 7 & 10)		1.25 10		
Power Dissipation Linear Derating Factor	(Notes 7 & 11)	P _D	1.8 14.3	W mW/°C	
	(Notes 8 & 10)		2.14 17.2		
	(Notes 7 & 10)	R _e JA	100		
Thermal Resistance, Junction to Ambient	(Notes 7 & 11)		70	900	
	(Notes 8 & 10)		58	°C/W	
Thermal Resistance, Junction to Lead	(Notes 10 & 12)	$R_{ heta JL}$	55		
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

- 6. AEC-Q101 V_{GS} maximum is $\pm 16V$.
- 7. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is 7. For a device surface mounted on 25mm x 25mm x 1.5mm FR4 PCB with high coverage of single sided 102 copper, in still air conditions, the device is measured when operating in a steady-state condition.
 8. Same as note (3), except the device is measured at t ≤ 10 sec.
 9. Same as note (3), except the device is pulsed with D = 0.02 and pulse width 300μs. The pulse current is limited by the maximum junction temperature.
 10. For a dual device with one active die.
 11. For a device with the experience of experience o

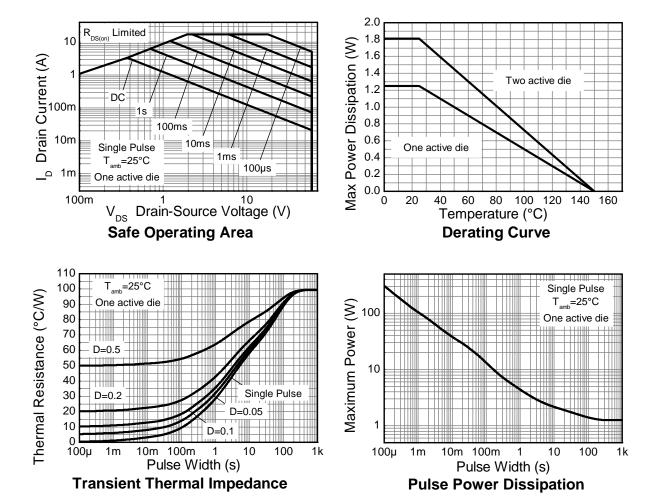
- 11. For a device with two active die running at equal power.

 12. Thermal resistance from junction to solder-point (at the end of the drain lead).

 13. UIS in production with L = 3.0mH, I_{AS} = 5.0A, R_{G} = 25 Ω , V_{DD} = 50V, starting T_{J} = +25°C.



Thermal Characteristics





Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

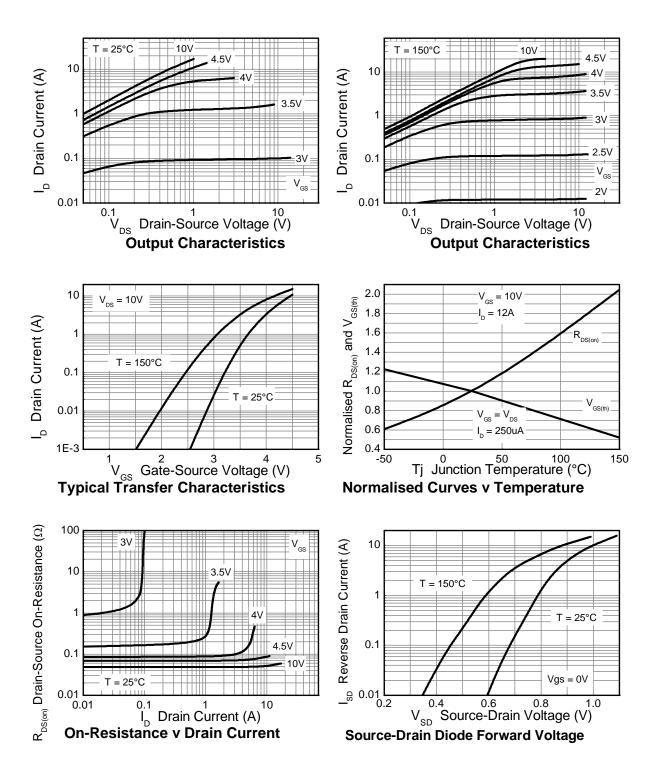
Characteristic	Symbol	Min	Тур	Max	Unit	Test Co	ondition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	_	V	$I_D = 250 \mu A, V_{GS} = 0 V$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	0.5	μΑ	V _{DS} = 60V, V _{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	V _{GS} = ±20V, V _{DS} =	= 0V
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	1.0	_	3.0	V	$I_{D}=250\mu A, V_{DS}=$	· V _{GS}
Static Drain-Source On-Resistance (Note 14)	J		0.048	0.066	Ω	$V_{GS} = 10V, I_D = 4.$	5A
Static Dialit-Source Off-Resistance (Note 14)	R _{DS (ON)}		0.068	0.097	22	V _{GS} = 4.5V, I _D = 3	5.5A
Forward Transconductance (Notes 14 & 15)	g _{fs}	_	19.2	_	S	V _{DS} = 15V, I _D = 6A	4
Diode Forward Voltage (Note 14)	V_{SD}	_	0.89	1.15	V	I _S = 4.5A, V _{GS} = 0	V
Reverse recovery time (Note 15)	t _{rr}		22.2	_	ns	-I _S = 1.9A, di/dt= 100A/μs	
Reverse recovery charge (Note 15)	Q_{rr}	_	16.9	_	nC		
DYNAMIC CHARACTERISTICS (Note 15)							
Input Capacitance	Ciss	_	502	_	pF	.,	0) /
Output Capacitance	Coss	_	45.7	_	рF	V _{DS} = 30V, V _{GS} = 0V f= 1MHz	
Reverse Transfer Capacitance	Crss	_	27.1	_	рF		
Total Gate Charge (Note 16)	Q_g	_	5.4	_	nC	V _{GS} = 4.5V	
Total Gate Charge (Note 16)	Q_g	_	10.3	_	nC		V _{DS} = 30V
Gate-Source Charge (Note 16)	Q_{gs}	_	1.7	_	nC	V _{GS} = 10V	I _D = 4.5A
Gate-Drain Charge (Note 16)	Q_{gd}	_	3.2	_	nC		
Turn-On Delay Time (Note 16)	t _{D(on)}	_	2.7	_	ns	V_{DD} = 30V, V_{GS} = 10V I_{D} = 1A, $R_{G} \cong 6.0\Omega$	
Turn-On Rise Time (Note 16)	t _r	_	2.4		ns		
Turn-Off Delay Time (Note 16)	t _{D(off)}	_	14.7	_	ns		
Turn-Off Fall Time (Note 16)	t _f	_	5.4		ns		

Notes:

^{14.} Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%.
15. For design aid only, not subject to production testing.
16. Switching characteristics are independent of operating junction temperatures.

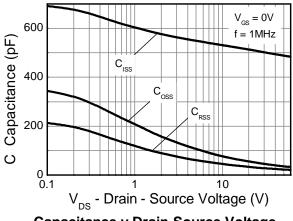


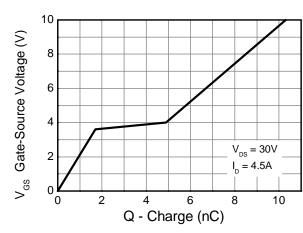
Typical Characteristics





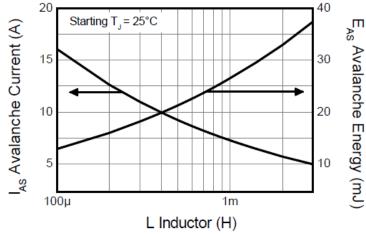
Typical Characteristics (continued)





Capacitance v Drain-Source Voltage

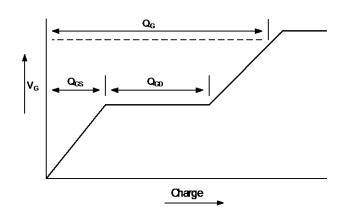
Gate-Source Voltage v Gate Charge

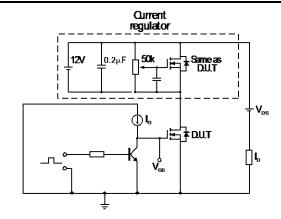


Single-Pulsed Avalanche Rating



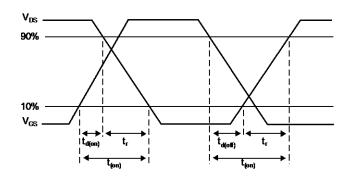
Test Circuits

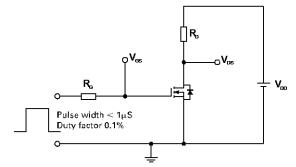




Basic gate charge waveform

Gate charge test circuit





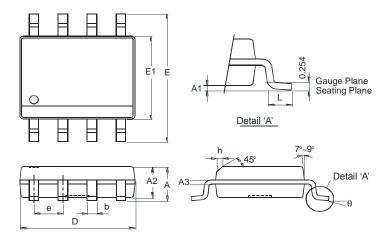
Switching time waveforms

Switching time test circuit



Package Outline Dimensions

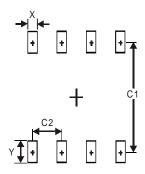
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



SO-8					
Dim	Min	Max			
Α	-	1.75			
A1	0.10	0.20			
A2	1.30	1.50			
А3	0.15	0.25			
b	0.3	0.5			
D	4.85	4.95			
Е	5.90	6.10			
E1	3.85	3.95			
е	1.27 Typ				
h	-	0.35			
L	0.62	0.82			
Θ	0°	8°			
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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